T2G6001528-Q3

18W, 28V, DC – 6 GHz, GaN RF Power Transistor

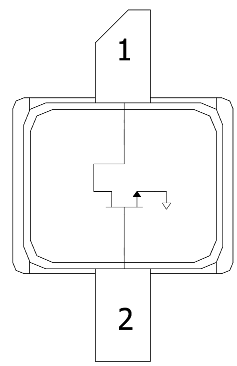
Applications

- Military radar
- Civilian radar
- Professional and military radio communications
- Test instrumentation
- Wideband or narrowband amplifiers
- Jammers

Product Features

- Frequency: DC to 6 GHz
- Output Power (P_{3dB}): 19 W at 5.2 GHz
- Linear Gain: >9 dB at 5.2 GHz
- Operating Voltage: 28 V
- Low thermal resistance package

Functional Block Diagram



General Description

The TriQuint T2G6001528-Q3 is an 18W (P_{3dB}) discrete GaN on SiC HEMT which operates from DC to 6.0 GHz. The device is constructed with TriQuint's proven TQGaN25 process, which features advanced field plate techniques to optimize power and efficiency at high drain bias operating conditions. This optimization can potentially lower system costs in terms of fewer amplifier line-ups and lower thermal management costs.

Lead-free and ROHS compliant

Evaluation boards are available upon request.

Pin Configuration

Pin No.	Label
1	V_D / RF OUT
2	V_G / RF IN
Flange	Source

Ordering Information

Part	ECCN	Description
T2G6001528-Q3	EAR99	Packaged part Flangeless
T2G6001528-Q3-EVB1	EAR99	5.0 – 6.0 GHz Evaluation Board

Absolute Maximum Ratings

Parameter	Value
Breakdown Voltage (BV_{DG})	100 V
Gate Voltage Range (V_G)	-7 to 0 V
Drain Current (I_D)	5 A
Gate Current (I_G)	-5 to 14 mA
Power Dissipation (P_D)	28 W
RF Input Power, CW, T = 25°C (P_{IN})	36 dBm
Channel Temperature (T_{CH})	275 °C
Mounting Temperature (30 Seconds)	320 °C
Storage Temperature	-40 to 150 °C

Operation of this device outside the parameter ranges given above may cause permanent damage. These are stress ratings only, and functional operation of the device at these conditions is not implied.

Recommended Operating Conditions

Parameter	Value
Drain Voltage (V_D)	28 V (Typ.)
Drain Quiescent Current (I_{DQ})	50 mA (Typ.)
Peak Drain Current (I_D)	1.4 A (Typ.)
Gate Voltage (V_G)	-3.2 V (Typ.)
Channel Temperature (T_{CH})	225 °C (Max)
Power Dissipation, CW (P_D)	20.9 W (Max)
Power Dissipation, Pulse (P_D)	22.5 W (Max)

Electrical specifications are measured at specified test conditions. Specifications are not guaranteed over all recommended operating conditions.

RF Characterization – Load Pull Performance at 3.0 GHz (1)

Test conditions unless otherwise noted: T_A = 25 °C, V_D = 28 V, I_{DQ} = 50 mA

Symbol	Parameter	Min	Typical	Max	Units
G_{LIN}	Linear Gain		16.5		dB
P_{3dB}	Output Power at 3 dB Gain Compression		19.6		W
DE_{3dB}	Drain Efficiency at 3 dB Gain Compression		69.6		%
PAE_{3dB}	Power-Added Efficiency at 3 dB Gain		66.4		%
G_{3dB}	Gain at 3 dB Compression		13.5		dB

Notes:

1. V_{DS} = 28 V, I_{DQ} = 50 mA; Pulse: 100µs, 20%

RF Characterization – Load Pull Performance at 6.0 GHz (1)

Test conditions unless otherwise noted: T_A = 25 °C, V_D = 28 V, I_{DQ} = 50 mA

Symbol	Parameter	Min	Typical	Max	Units
G_{LIN}	Linear Gain		11.3		dB
P_{3dB}	Output Power at 3 dB Gain Compression		19.0		W
DE_{3dB}	Drain Efficiency at 3 dB Gain Compression		66.0		%
PAE_{3dB}	Power-Added Efficiency at 3 dB Gain		56.2		%
G_{3dB}	Gain at 3 dB Compression		8.3		dB

Notes:

1. V_{DS} = 28 V, I_{DQ} = 50 mA; Pulse: 100µs, 20%

RF Characterization – Performance at 5.2 GHz (1, 2)

Test conditions unless otherwise noted: T_A = 25 °C, V_D = 28 V, I_{DQ} = 50 mA

Symbol	Parameter	Min	Typical	Max	Units
G_{LIN}	Linear Gain		10.5		dB
P_{3dB}	Output Power at 3 dB Gain Compression		17.3		W
DE_{3dB}	Drain Efficiency at 3 dB Gain Compression		48.0		%
G_{3dB}	Gain at 3 dB Compression		7.5		dB

Notes:
1. Performance at 5.2 GHz in the 5.0 to 6.0 GHz Evaluation Board
2. V_{DS} = 28 V, I_{DQ} = 50 mA; Pulse: 100µs, 20%

RF Characterization – Narrow Band Performance at 3.50 GHz (1)

Test conditions unless otherwise noted: T_A = 25 °C, V_D = 28 V, I_{DQ} = 50 mA

Symbol	Parameter	Typical
VSWR	Impedance Mismatch Ruggedness	10:1

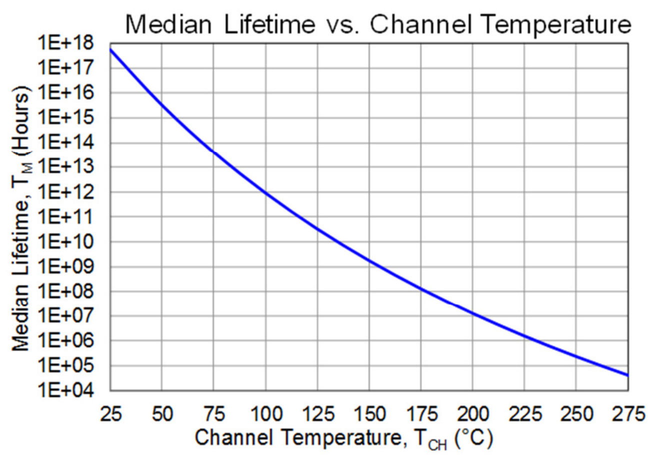
Notes:
1. V_{DS} = 28 V, I_{DQ} = 50 mA, CW at P_{1dB}

Thermal and Reliability Information

Parameter	Test Conditions	Value	Units
Thermal Resistance (θ_{JC})	DC at 85 °C Case	6.7	ºC/W
Channel Temperature (T_{CH})		225	°C

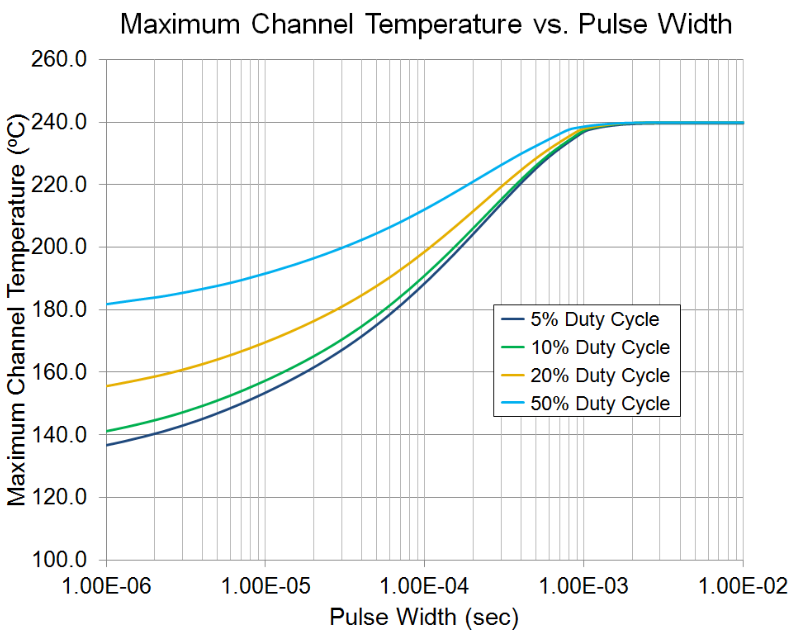
Notes:
Thermal resistance measured to bottom of package, CW.

Median Lifetime



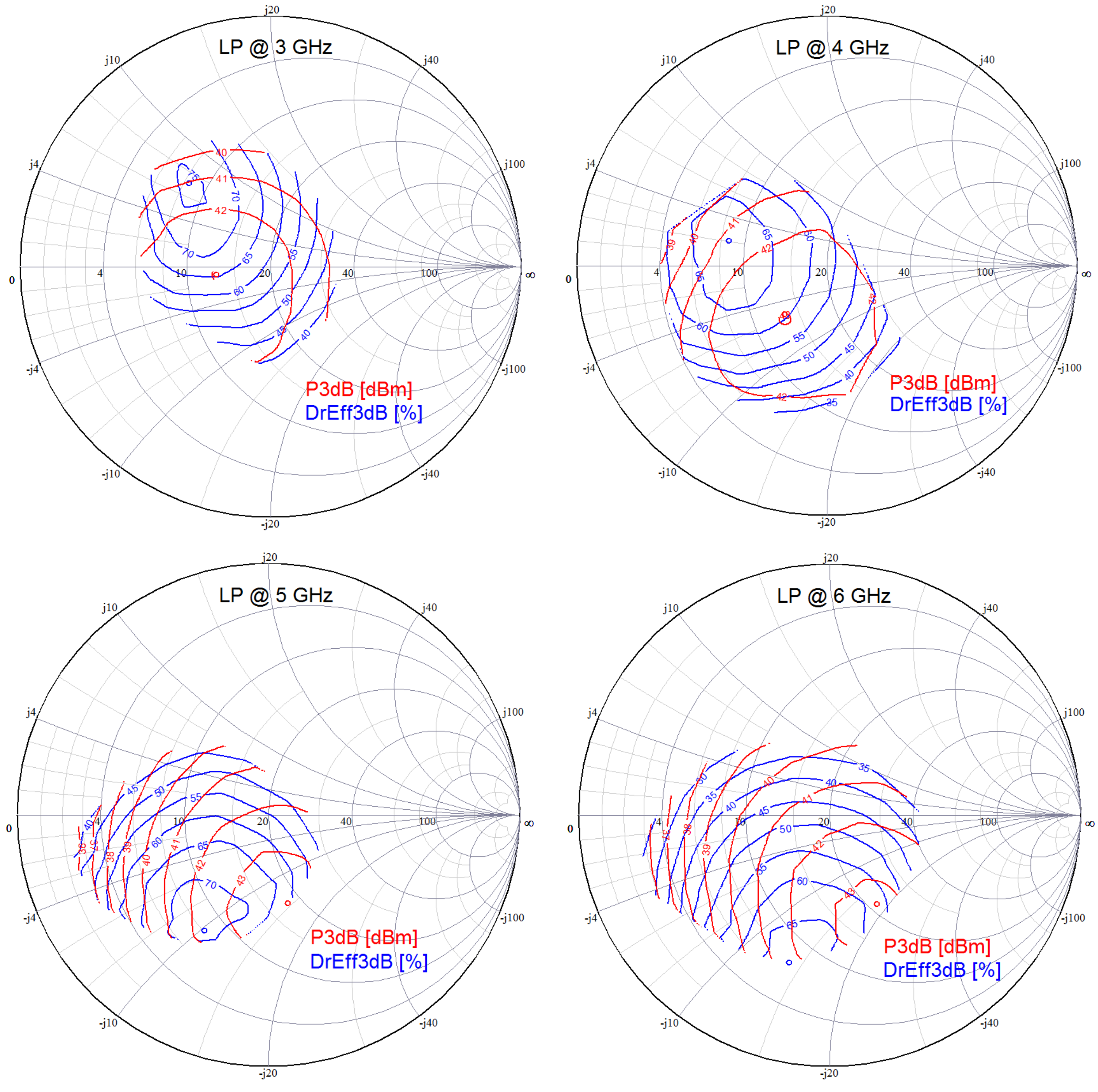
Maximum Channel Temperature

T_{BASE} = 85 °C, P_D = 22.5 W



Load Pull Smith Charts (1, 2)

RF performance that the device typically exhibits when placed in the specified impedance environment. The impedances are not the impedances of the device, they are the impedances presented to the device via an RF circuit or load-pull system. The impedances listed follow an optimized trajectory to maintain high power and high efficiency.

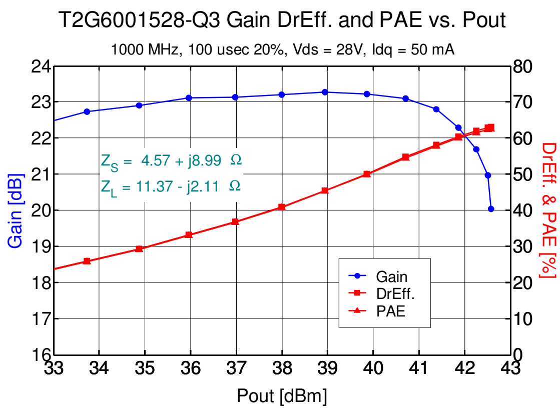


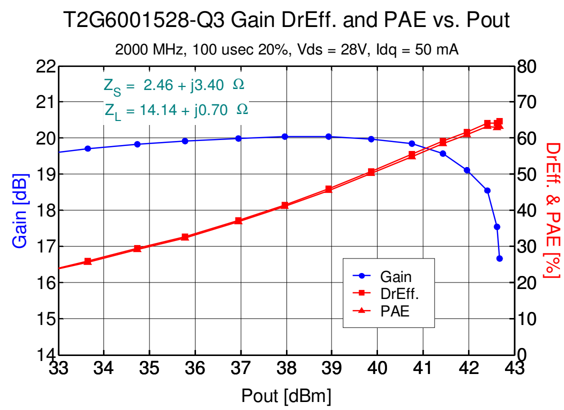
Notes:

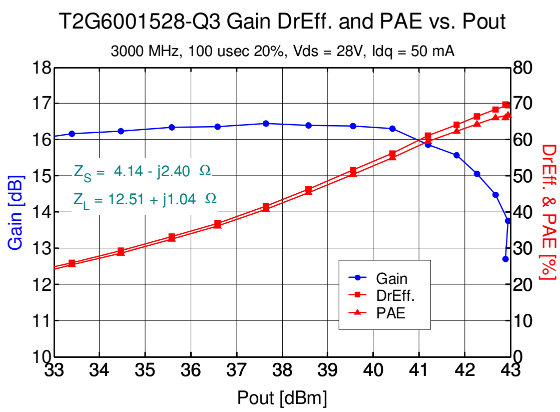
1. Test Conditions: V_{DS} = 28 V, I_{DQ} = 50 mA
2. Test Signal: Pulse Width = 100 µsec, Duty Cycle = 20%

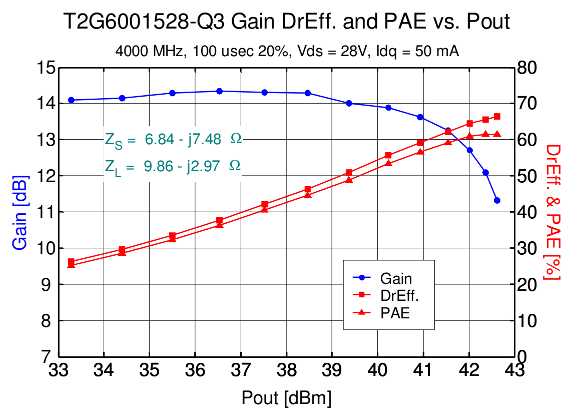
Typical Performance

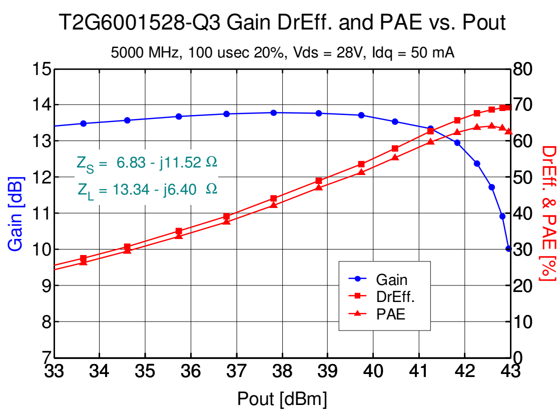
Performance is based on compromised impedance point and measured at DUT reference plane.

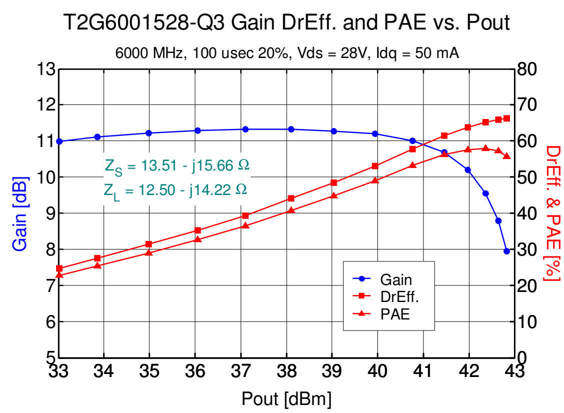






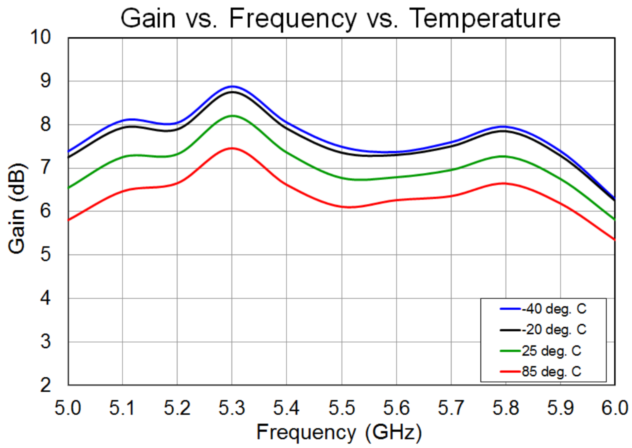


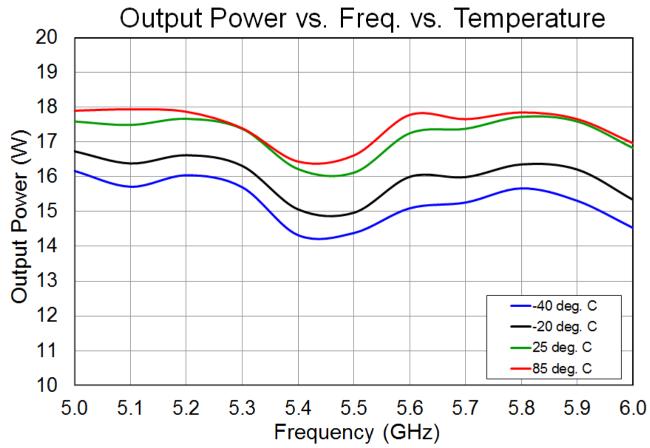


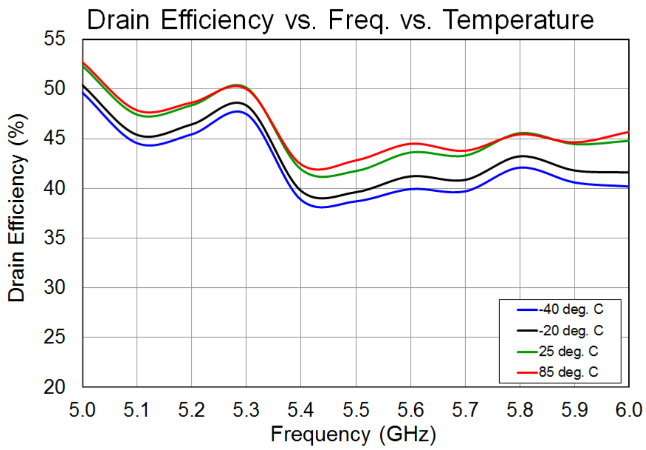


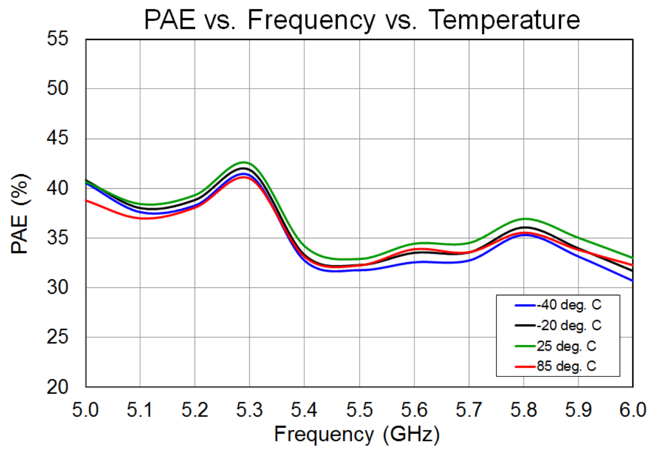
Performance Over Temperature [1, 2]

Performance measured in TriQuint's 5.0 GHz to 6.0 GHz Evaluation Board at 3 dB compression.







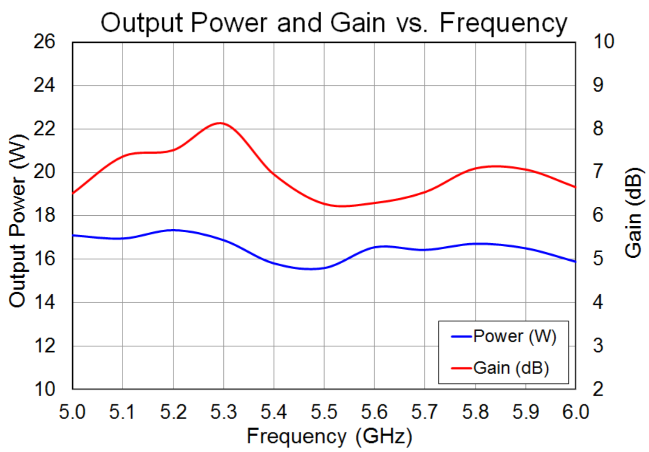


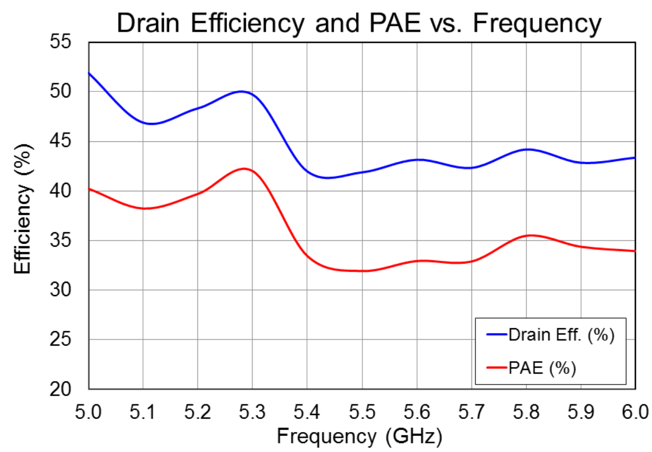
Notes:

1. Test Conditions: V_{DS} = 28 V, I_{DQ} = 50 mA
2. Test Signal: Pulse Width = 100 µs, Duty Cycle = 20%

Evaluation Board Performance [1, 2]

Performance at 3 dB Compression

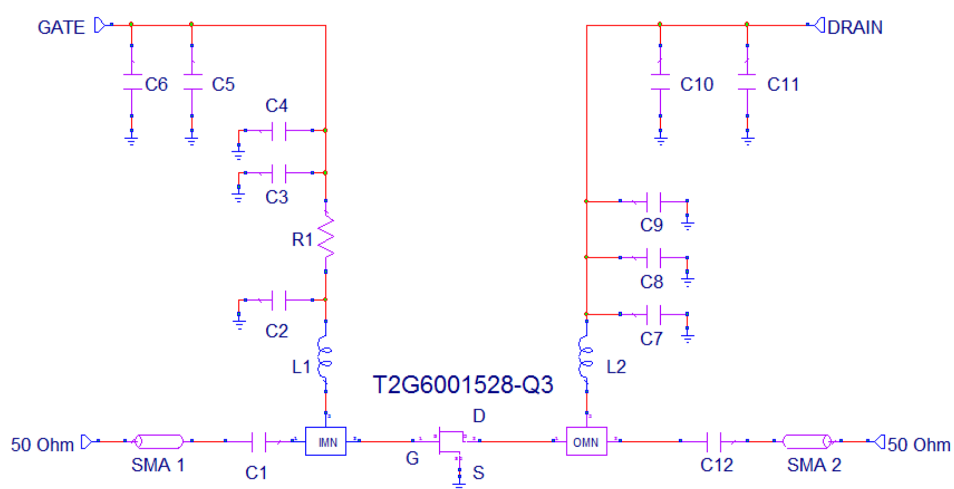




Notes:

1. Test Conditions: V_{DS} = 28 V, I_{DQ} = 50 mA
2. Test Signal: Pulse Width = 100 µs, Duty Cycle = 20 %

Application Circuit



Bias-up Procedure

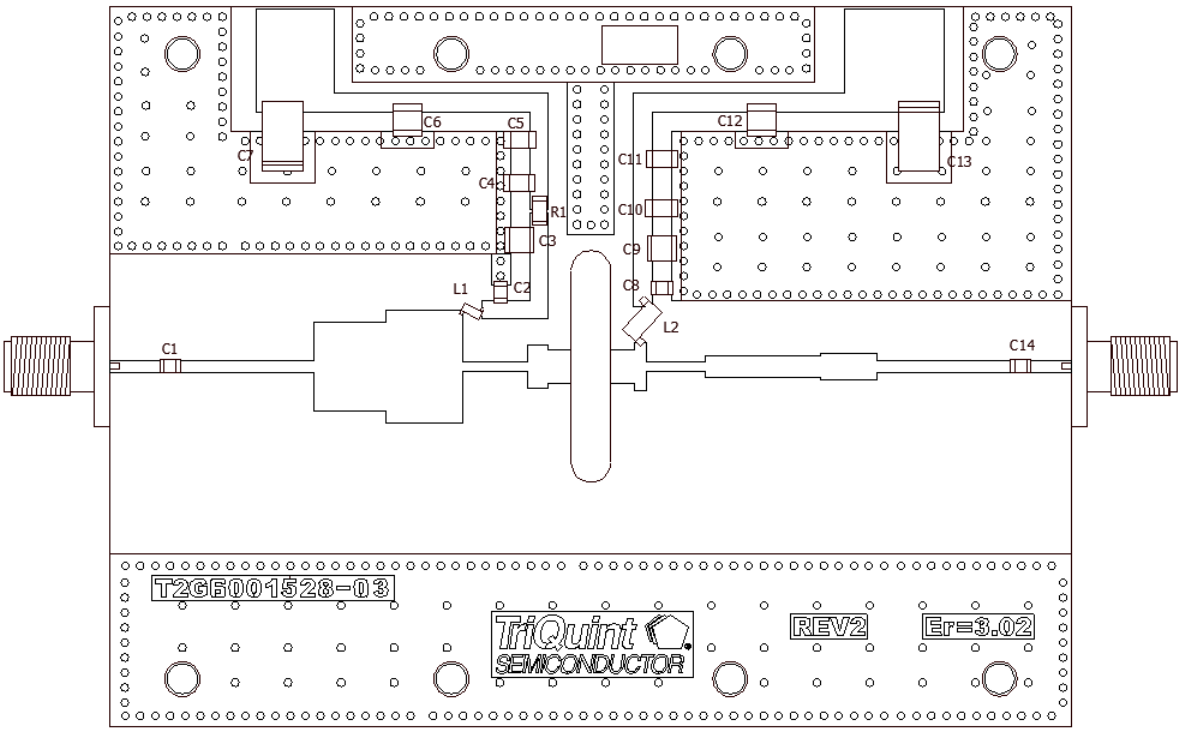
Set gate voltage (V_G) to -5.0V
Set drain voltage (V_D) to 28 V
Slowly increase V_G until quiescent I_D is 50 mA.
Apply RF signal

Bias-down Procedure

Turn off RF signal
Turn off V_D and wait 1 second to allow drain capacitor dissipation
Turn off V_G

Evaluation Board Layout

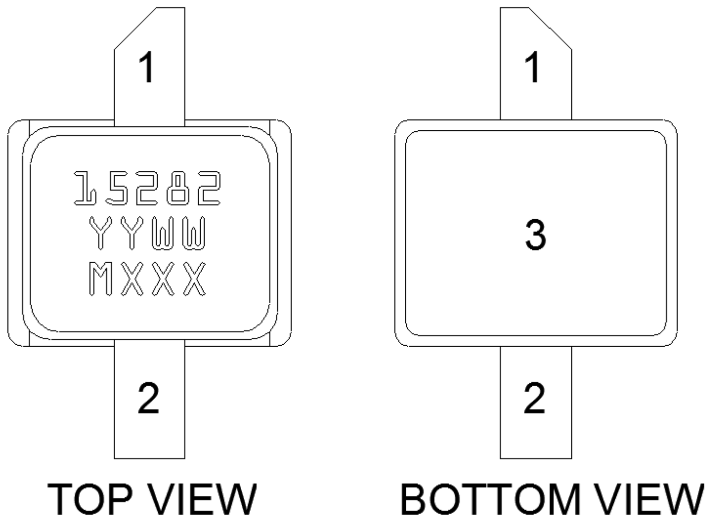
Top RF layer is 0.020" thick Rogers RO3203, ε_r = 3.02. The pad pattern shown has been developed and tested for optimized assembly at TriQuint Semiconductor. The PCB land pattern has been developed to accommodate lead and package tolerances.



Bill of Materials

Reference Design	Value	Qty	Manufacturer	Part Number
C1, C14	100 pF	2	ATC	100A101JW500XC
C2, C8	2400 pF	1	Dielectric Labs	C08BL242X-5UN-XOB
C3, C9	100 pF	2	ATC	100B101GT500X
C4, C10	0.01 uF	2	Kemet	C1206C103K1RACTU
C5, C11	0.1 uF	2	Kemet	C1206C104K1RACTU
C6, C12	1.0 uF	2	AVX	1812C105KAT2A
C7, C13	22 uF	2	Sprague	226K035AT
L1	5.4 nH	1	Coilcraft	0906-5JL
L2	9.85 nH	1	Coilcraft	1606-9JLB
R1	12.1Ohms	1	Vishay	CRC120612R1FKEA

Pin Layout



Note:
The T2G6001528-Q3 will be marked with the "15282" designator and a lot code marked below the part designator. The "YY" represents the last two digits of the calendar year the part was manufactured, the "WW" is the work week of the assembly lot start, and the "MXXX" is the production lot number.

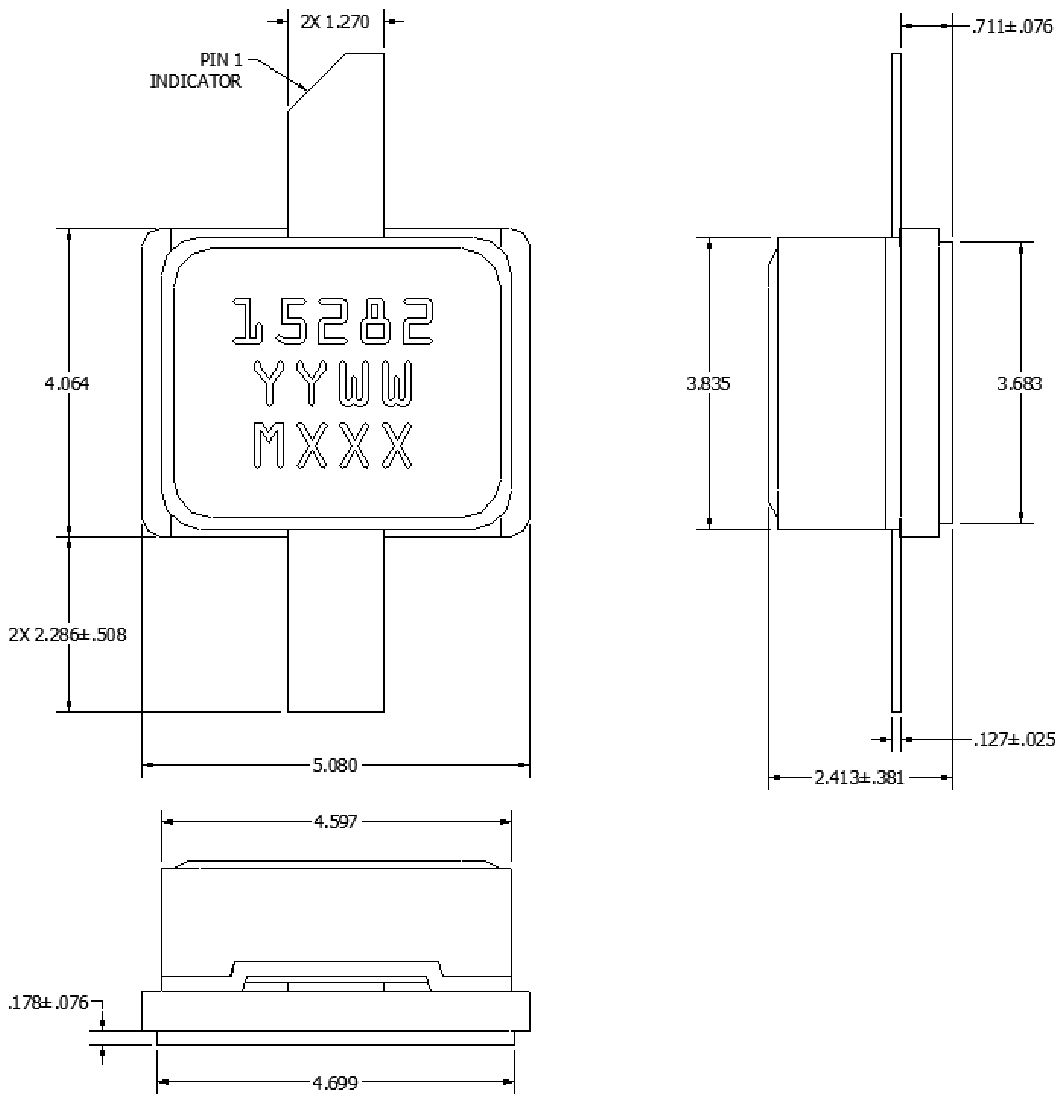
Pin Description

Pin	Symbol	Description
1	V_D / RF OUT	Drain voltage / RF Output matched to 50 ohms; see EVB Layout on page 9 as an example.
2	V_G / RF IN	Gate voltage / RF Input matched to 50 ohms; see EVB Layout on page 9 as an example.
3	Flange	Source connected to ground; see EVB Layout on page 9 as an example.

Notes:
Thermal resistance measured to bottom of package

Mechanical Information

All dimensions are in millimeters. Unless specified otherwise, tolerances are ± 0.127.



Note:
This package is lead-free/RoHS-compliant. The plating material on the leads is NiAu. It is compatible with both lead-free (maximum 260 °C reflow temperature) and tin-lead (maximum 245°C reflow temperature) soldering processes.

Product Compliance Information

ESD Sensitivity Ratings

Caution! ESD-Sensitive Device

ESD Rating:	Class 1A
Value:	Passes ≥ 250 V to < 500 V max.
Test:	Human Body Model (HBM)
Standard:	JEDEC Standard JESD22-A114

MSL Rating

Level 3 at +260 °C convection reflow
The part is rated Moisture Sensitivity Level 3 at 260°C per JEDEC standard IPC/JEDEC J-STD-020.

Solderability

Compatible with the latest version of J-STD-020, Lead free solder, 260° C

RoHs Compliance

This part is compliant with EU 2002/95/EC RoHS directive (Restrictions on the Use of Certain Hazardous Substances in Electrical and Electronic Equipment).

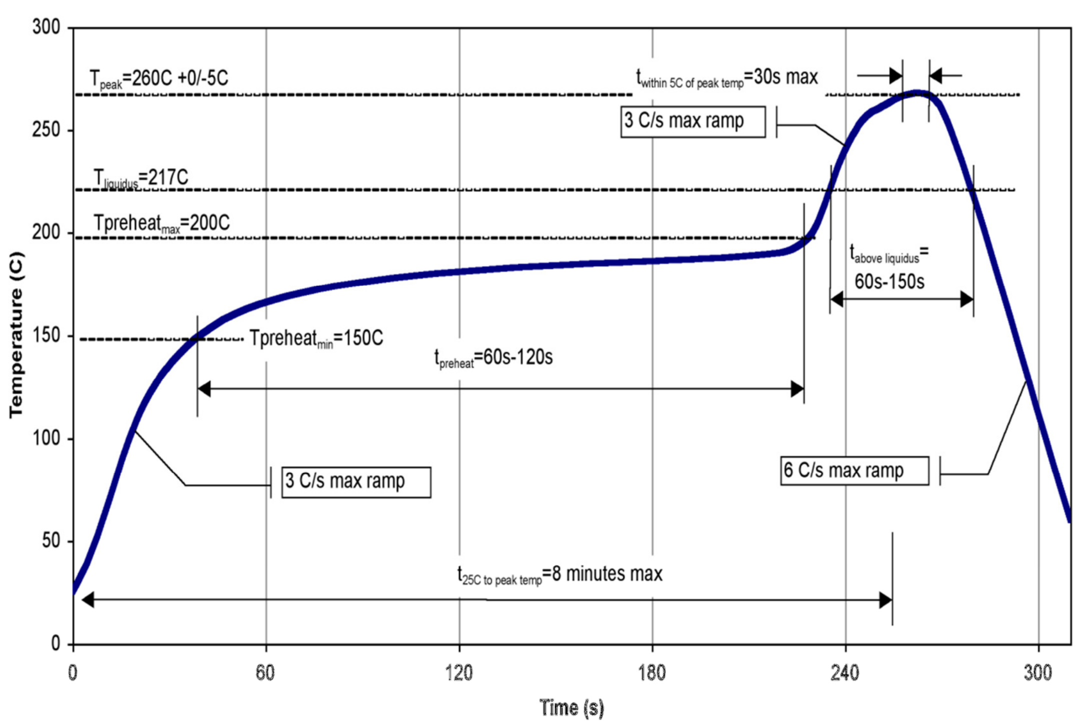
This product also has the following attributes:

- Lead Free
- Halogen Free (Chlorine, Bromine)
- Antimony Free
- TBBP-A ($C_{15}H_{12}Br_4O_2$) Free
- PFOS Free
- SVHC Free

ECCN

US Department of Commerce EAR99

Recommended Soldering Temperature Profile



Contact Information

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